G3R160MT17J
1700 V 160 mΩ SiC MOSFET

Silicon Carbide MOSFET
N-Channel Enhancement Mode

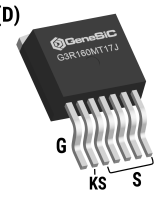
V_{DS}	=	1700 V
$R_{DS(ON)(Typ.)}$	=	160 mΩ
$I_{D(T_C = 100°C)}$	=	13 A

Features

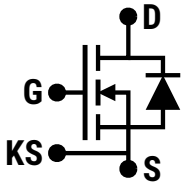
- G3R™ Technology with +15 V Gate Drive
- Softer $R_{DS(ON)}$ v/s Temperature Dependency
- LoRing™ - Electromagnetically Optimized Design
- Smaller $R_{G(INT)}$ and Lower Q_G
- Low Device Capacitances (C_{OSS}, C_{RSS})
- Superior Cost-Performance Index
- Robust Body Diode with Low V_F and Low Q_{RR}
- Optimized Package with Separate Driver Source Pin

Package

Case(D)



TO-263-7



D = Drain
G = Gate
S = Source
KS = Kelvin Source

RoHS

REACH

Advantages

- Compatible with Commercial Gate Drivers
- Low Conduction Losses at all Temperatures
- Reduced Ringing
- Faster and More Efficient Switching
- Lesser Switching Spikes and Lower Losses
- Better Power Density and System Efficiency
- Ease of Paralleling without Thermal Runaway
- Superior Robustness and System Reliability

Applications

- Solar Inverter
- EV Fast Charging
- Switched Mode Power Supply (SMPS)
- Auxiliary Power Supply
- High Voltage Converter
- Pulsed Power

Absolute Maximum Ratings (At T_C = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Drain-Source Voltage	$V_{DS(max)}$	V_{GS} = 0 V, I_D = 100 µA	1700	V	
Gate-Source Voltage (Dynamic)	$V_{GS(max)}$		-10 / +20	V	
Gate-Source Voltage (Static)	$V_{GS(op)}$	Recommended Operation	-5 / +15	V	
Continuous Forward Current	I_D	T_C = 25°C, V_{GS} = -5 / +15 V T_C = 100°C, V_{GS} = -5 / +15 V T_C = 135°C, V_{GS} = -5 / +15 V	18 13 9	A	Fig. 15
Pulsed Drain Current	$I_{D(pulse)}$	t_P ≤ 3µs, D ≤ 1%, V_{GS} = 15 V, Note 1	32	A	Fig. 14
Power Dissipation	P_D	T_C = 25°C	145	W	Fig. 16
Non-Repetitive Avalanche Energy	E_{AS}	L = 12.6 mH, I_{AS} = 5.0 A	158	mJ	
Operating and Storage Temperature	T_j, T_{stg}		-55 to 175	°C	

Thermal/Package Characteristics

Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Thermal Resistance, Junction - Case	R_{thJC}			0.87	1.04	°C/W	Fig. 13
Weight	W_T			1.45		g	

Note 1: Pulse Width t_P Limited by $T_{j(max)}$

Electrical Characteristics (At T_C = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Drain-Source Breakdown Voltage	V_{DSS}	V_{GS} = 0 V, I_D = 100 µA	1700			V	
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 1700 V, V_{GS} = 0 V		1		µA	
Gate Source Leakage Current	I_{GSS}	V_{DS} = 0 V, V_{GS} = 20 V V_{DS} = 0 V, V_{GS} = -10 V			100 -100	nA	
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 10.0 mA V_{DS} = V_{GS}, I_D = 10.0 mA, T_j = 175°C	1.8	2.70 1.90		V	Fig. 9
Transconductance	g_{fs}	V_{DS} = 10 V, I_D = 10 A V_{DS} = 10 V, I_D = 10 A, T_j = 175°C		4.6 4.8		S	Fig. 4
Drain-Source On-State Resistance	$R_{DS(ON)}$	V_{GS} = 15 V, I_D = 10 A V_{GS} = 15 V, I_D = 10 A, T_j = 175°C		160 321	224	mΩ	Fig. 5-8
Input Capacitance	C_{iss}	V_{DS} = 1000 V, V_{GS} = 0 V f = 1 MHz, V_{AC} = 25mV		854		pF	Fig. 11
Output Capacitance	C_{oss}			23			
Reverse Transfer Capacitance	C_{rss}			4.1			
C_{oss} Stored Energy	E_{oss}			15		µJ	Fig. 12
C_{oss} Stored Charge	Q_{oss}			46		nC	
Effective Output Capacitance (Energy Related)	$C_{o(er)}$			30		pF	Note 2
Effective Output Capacitance (Time Related)	$C_{o(tr)}$			46			
Gate-Source Charge	Q_{gs}	V_{DS} = 1000 V, V_{GS} = -5 / +15 V I_D = 10 A Per IEC607478-4		9		nC	Fig. 10
Gate-Drain Charge	Q_{gd}			9			
Total Gate Charge	Q_g			29			
Internal Gate Resistance	$R_{G(int)}$	f = 1 MHz, V_{AC} = 25 mV		1.6		Ω	
Turn-On Switching Energy (Body Diode)	E_{On}	T_j = 25°C, V_{GS} = -5/+15V, $R_{G(ext)}$ = 8 Ω, L = 220.0 µH, I_D = 10 A, V_{DD} = 1200 V		107		µJ	Fig. 22,26
Turn-Off Switching Energy (Body Diode)	E_{Off}			23			
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 1200 V, V_{GS} = -5/+15V $R_{G(ext)}$ = 8 Ω, L = 220.0 µH, I_D = 10 A Timing relative to V_{DS}, Inductive load		14		ns	Fig. 24
Rise Time	t_r			11			
Turn-Off Delay Time	$t_{d(off)}$			16			
Fall Time	t_f			9			

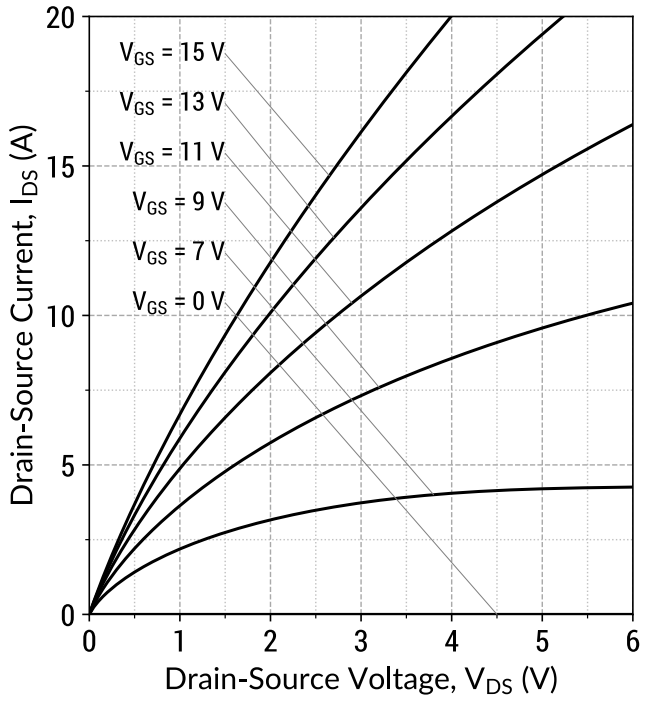
**The chip technology was characterized up to 200 V/ns. The measured dV/dt was limited by measurement test setup and package.*

Note 2: $C_{o(er)}$, a lumped capacitance that gives same stored energy as C_{OSS} while V_{DS} is rising from 0 to 1000V.
$C_{o(tr)}$, a lumped capacitance that gives same charging times as C_{OSS} while V_{DS} is rising from 0 to 1000V.

Reverse Diode Characteristics

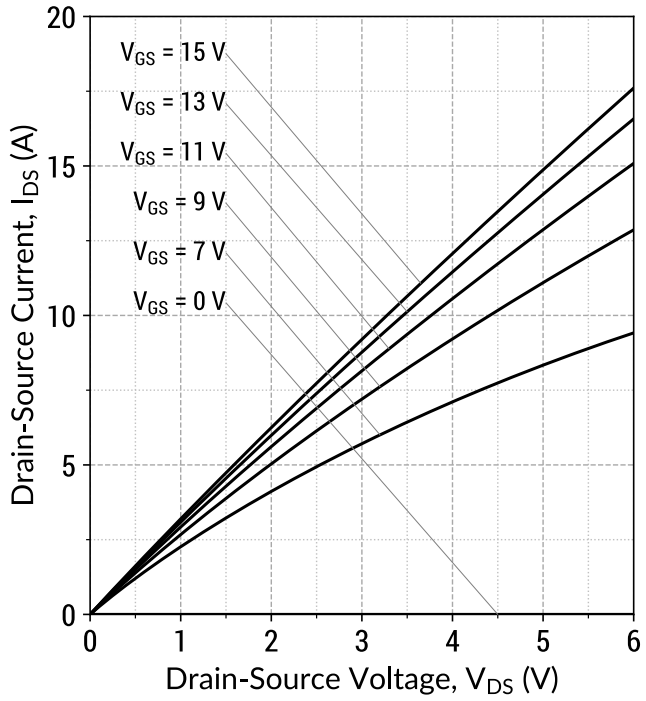
Parameter	Symbol	Conditions	Values			Unit	Note
			Min.	Typ.	Max.		
Diode Forward Voltage	V_{SD}	V_{GS} = -5 V, I_{SD} = 5 A		4.6		V	Fig. 17-18
		V_{GS} = -5 V, I_{SD} = 5 A, T_j = 175°C		4.3			
Continuous Diode Forward Current	I_S	V_{GS} = -5 V, T_c = 100°C	12			A	
Diode Pulse Current	$I_{S(pulse)}$	V_{GS} = -5 V, Note 1		48		A	
Reverse Recovery Time	t_{rr}	V_{GS} = -5 V, I_{SD} = 10 A, V_R = 1200 V dif/dt = 1400 A/µs, T_j = 25°C		26		ns	
Reverse Recovery Charge	Q_{rr}			81		nC	
Peak Reverse Recovery Current	I_{rrm}			5		A	
Reverse Recovery Time	t_{rr}	V_{GS} = -5 V, I_{SD} = 10 A, V_R = 1200 V dif/dt = 1400 A/µs, T_j = 175°C		45		ns	
Reverse Recovery Charge	Q_{rr}			304		nC	
Peak Reverse Recovery Current	I_{rrm}			12		A	

Figure 1: Output Characteristics (T_j = 25°C)



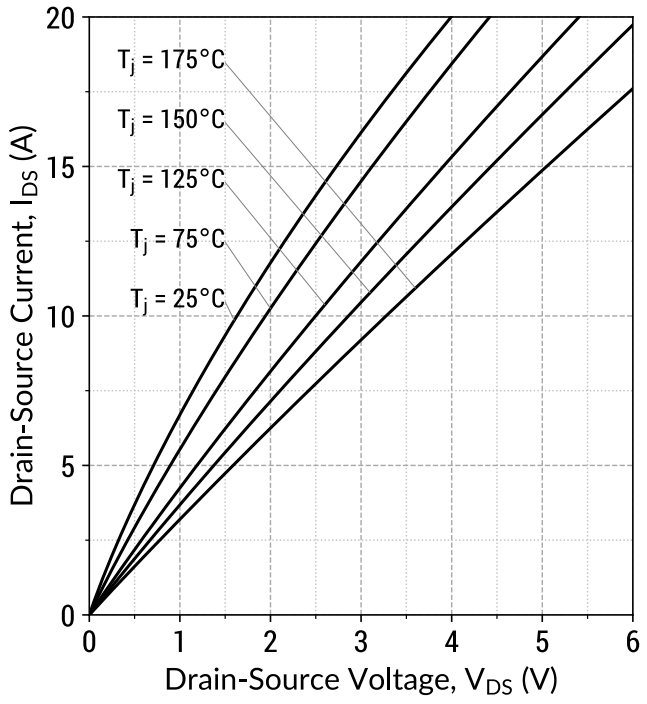
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 2: Output Characteristics (T_j = 175°C)



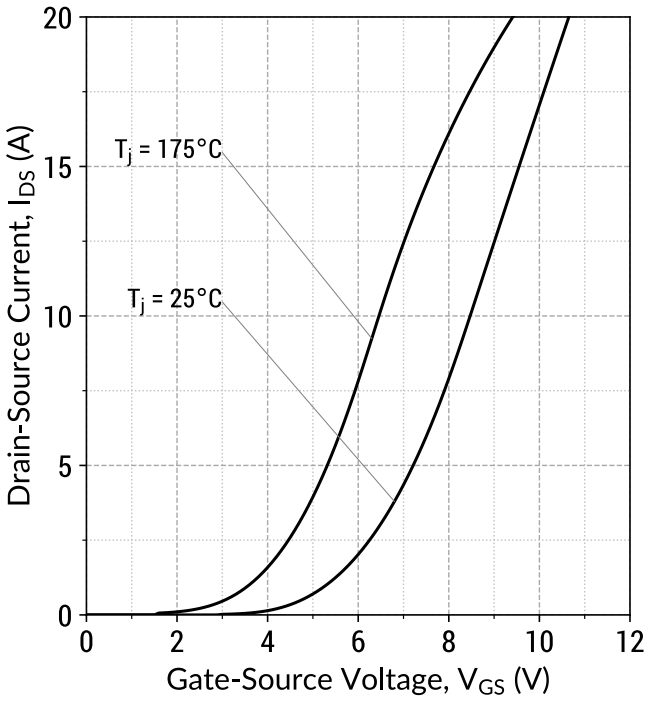
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 3: Output Characteristics (V_{GS} = 15 V)



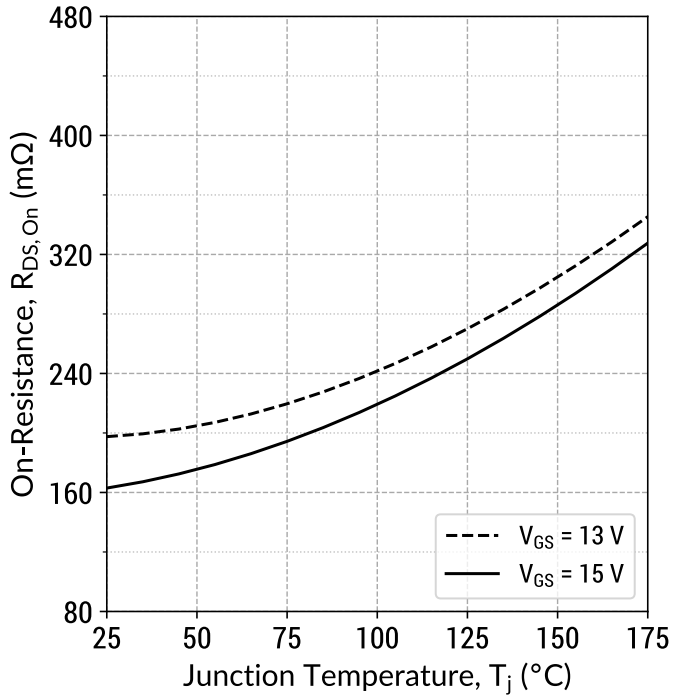
$I_D = f(V_{DS}, T_j)$; t_P = 250 µs

Figure 4: Transfer Characteristics (V_{DS} = 10 V)



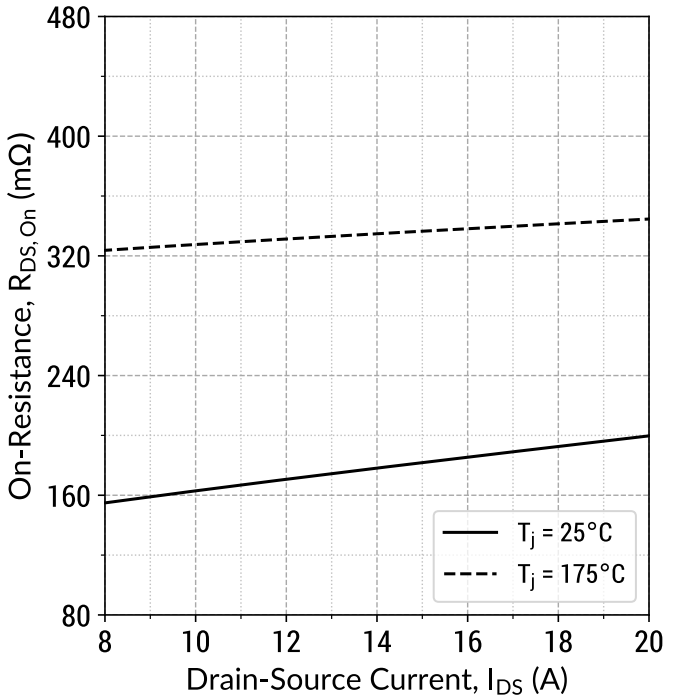
$I_D = f(V_{GS}, T_j)$; t_P = 100 µs

Figure 5: On-State Resistance v/s Temperature



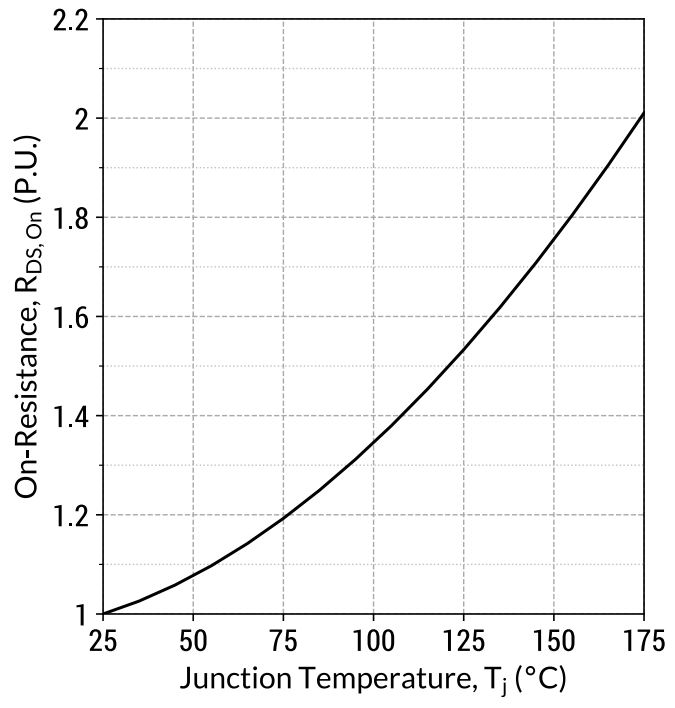
$R_{DS(ON)} = f(T_j, V_{GS})$; t_P = 250 µs; I_D = 10 A

Figure 6: On-State Resistance v/s Drain Current



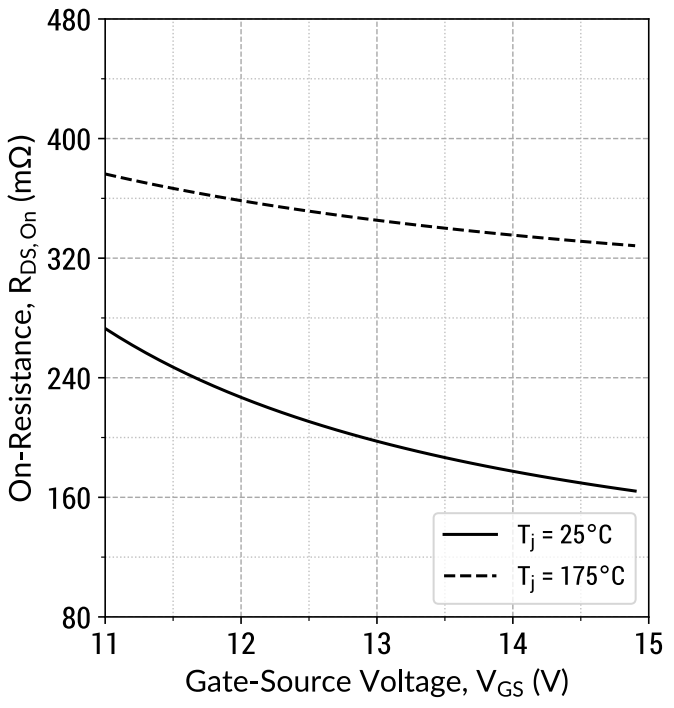
$R_{DS(ON)} = f(T_j, I_D)$; t_P = 250 µs; V_{GS} = 15 V

Figure 7: Normalized On-State Resistance v/s Temperature



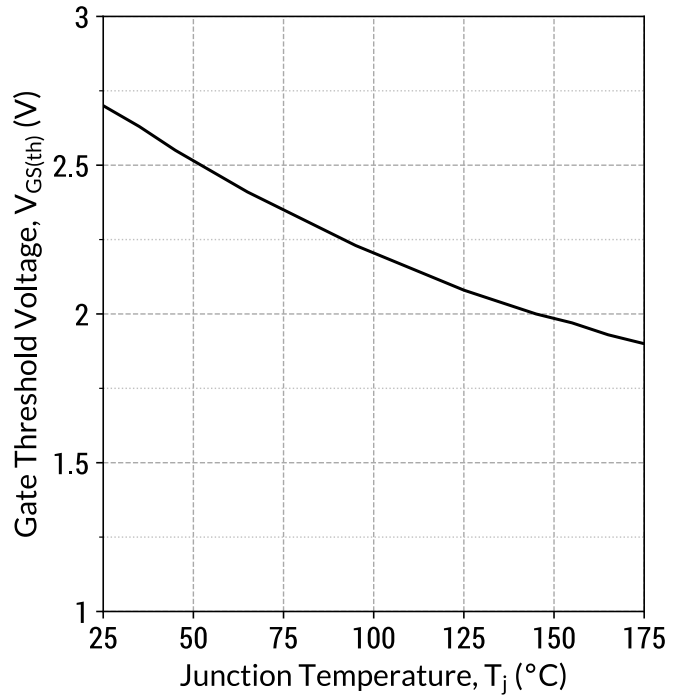
$R_{DS(ON)} = f(T_j)$; t_P = 250 µs; I_D = 10 A; V_{GS} = 15 V

Figure 8: On-State Resistance v/s Gate Voltage



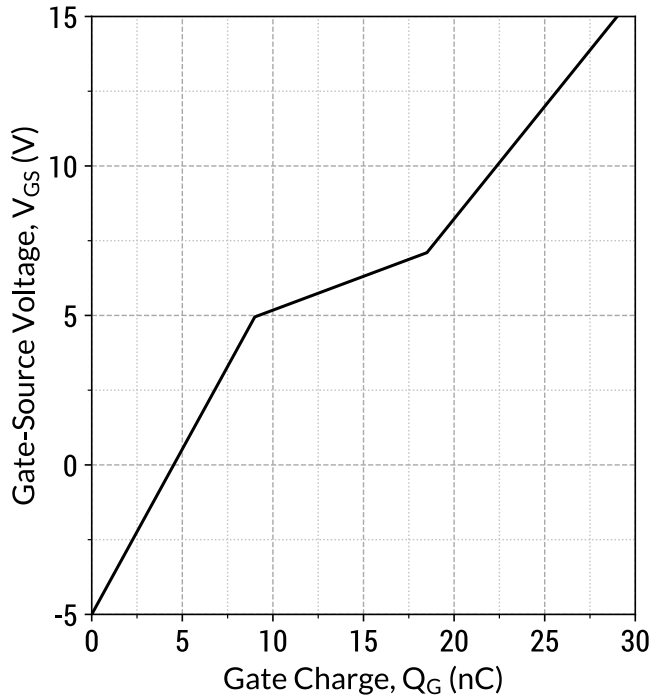
$R_{DS(ON)} = f(T_j, V_{GS})$; t_P = 250 µs; I_D = 10 A

Figure 9: Threshold Voltage Characteristics



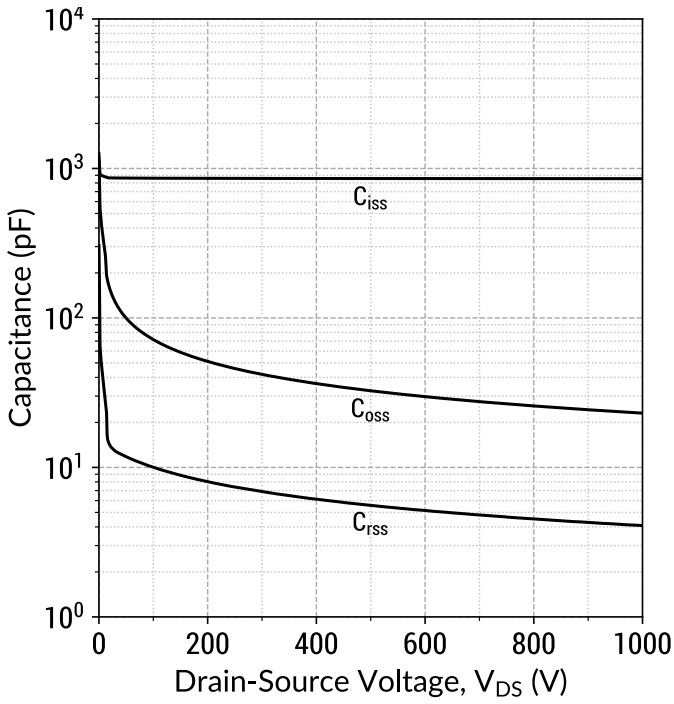
$V_{GS(th)} = f(T_j)$; $V_{DS} = V_{GS}$; I_D = 10.0 mA

Figure 10: Gate Charge Characteristics



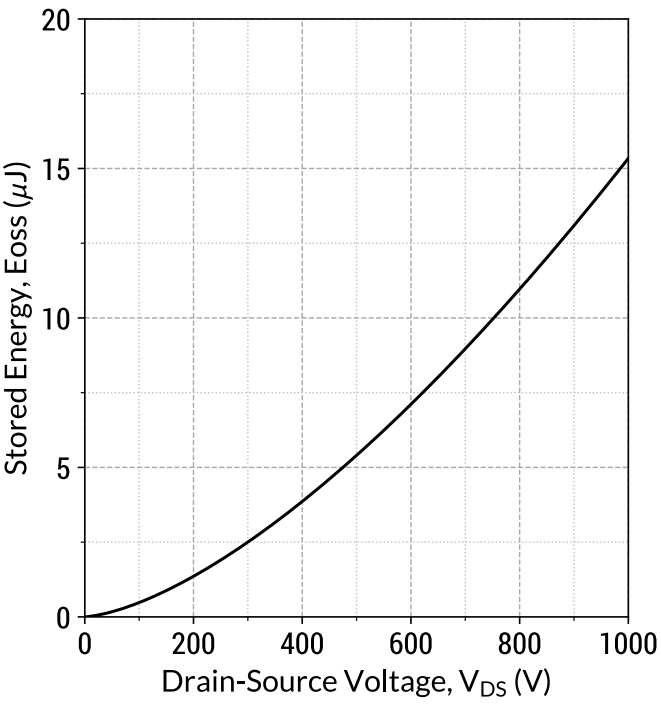
I_D = 10 A; V_{DS} = 1000 V; T_c = 25°C

Figure 11: Capacitance v/s Drain-Source Voltage



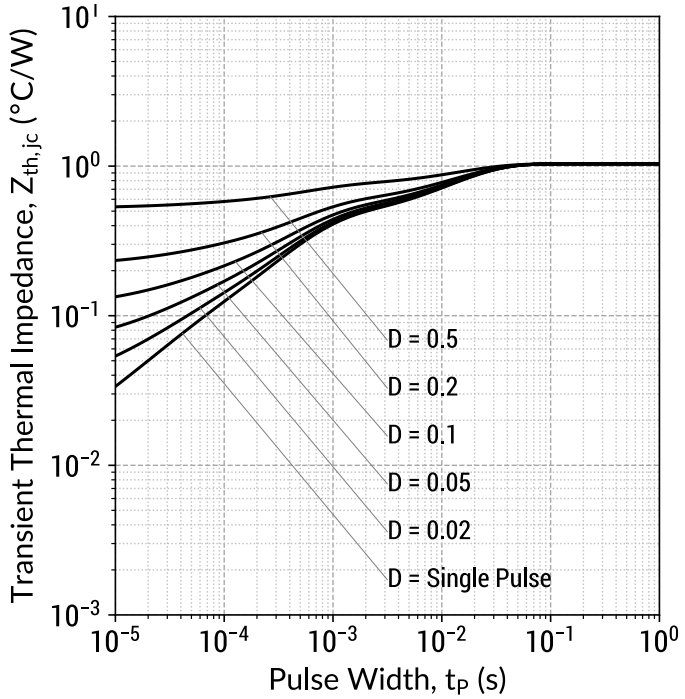
f = 1 MHz; V_{AC} = 25mV

Figure 12: Output Capacitor Stored Energy



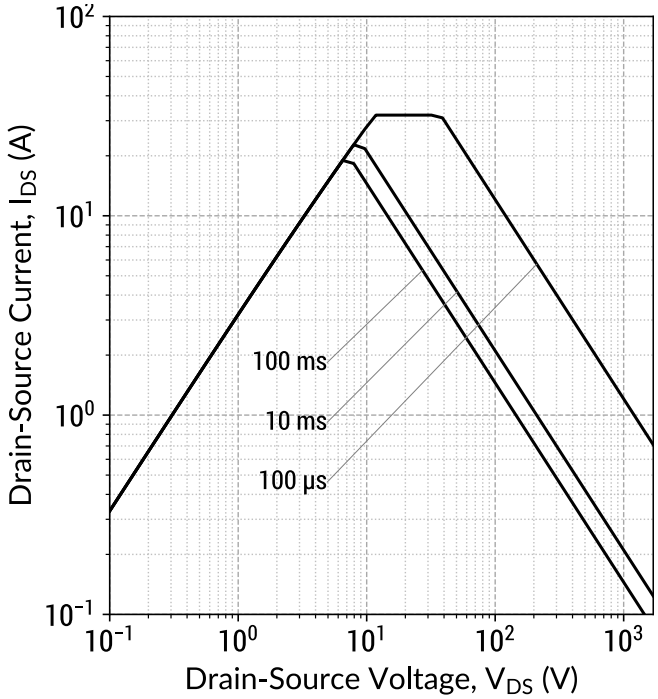
$E_{oss} = f(V_{DS})$

Figure 13: Transient Thermal Impedance



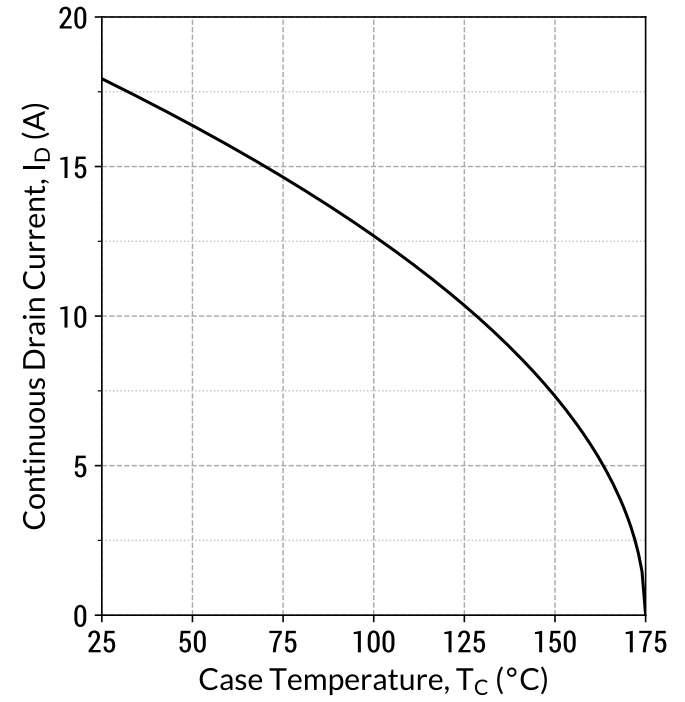
$Z_{th,jc} = f(t_P,D)$; $D = t_P/T$

Figure 14: Safe Operating Area (T_c = 25°C)



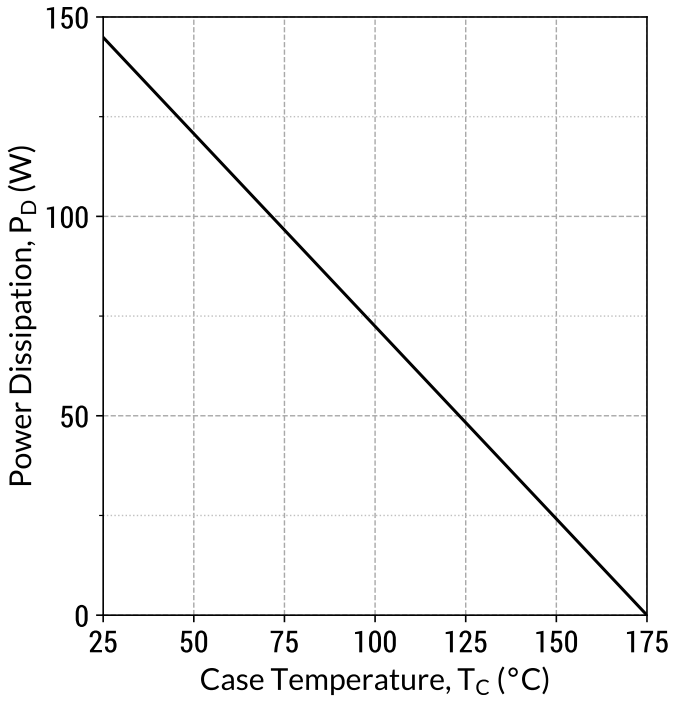
$I_D = f(V_{DS}, t_P)$; $T_j \leq 175$°C; $D = 0$

Figure 15: Current De-rating Curve



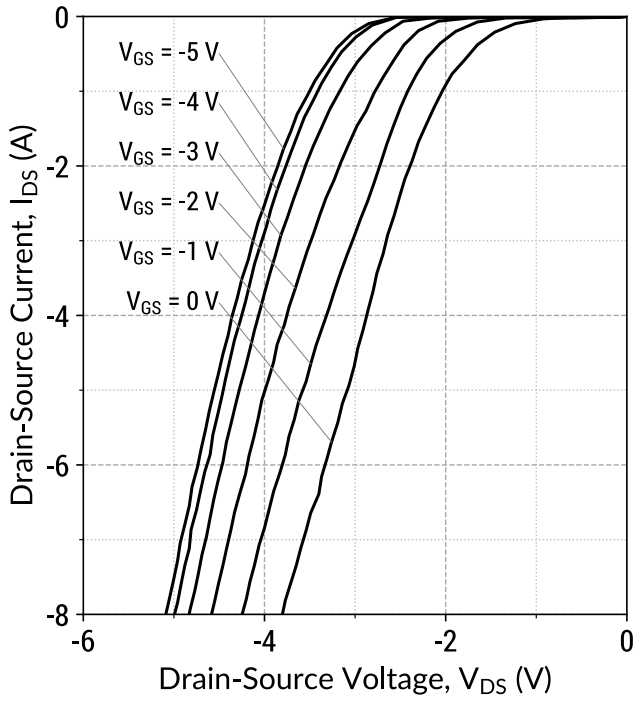
$I_D = f(T_C)$; $T_j \leq 175$°C

Figure 16: Power De-rating Curve



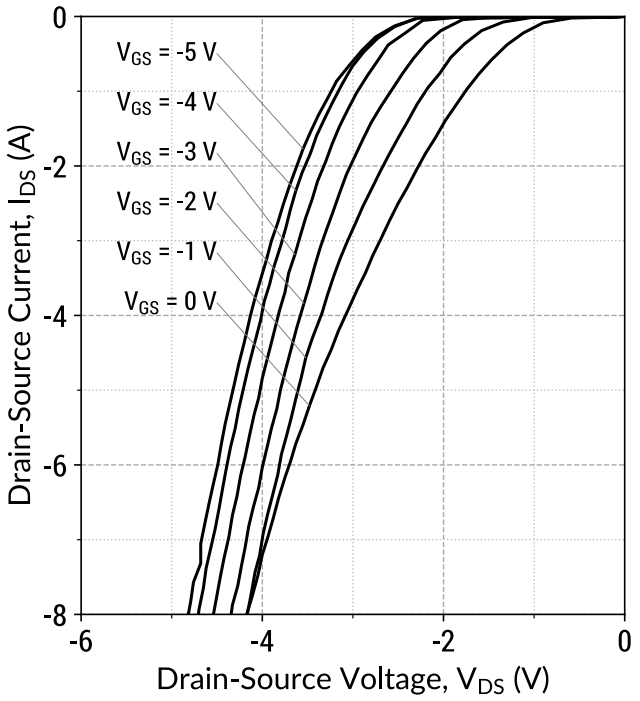
$P_D = f(T_C)$; $T_j \leq 175$°C

Figure 17: Body Diode Characteristics (T_j = 25°C)



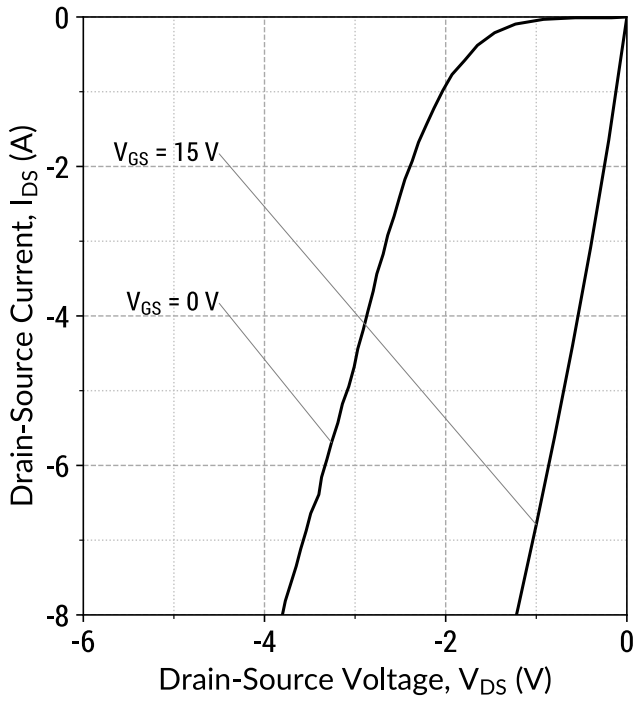
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 18: Body Diode Characteristics (T_j = 175°C)



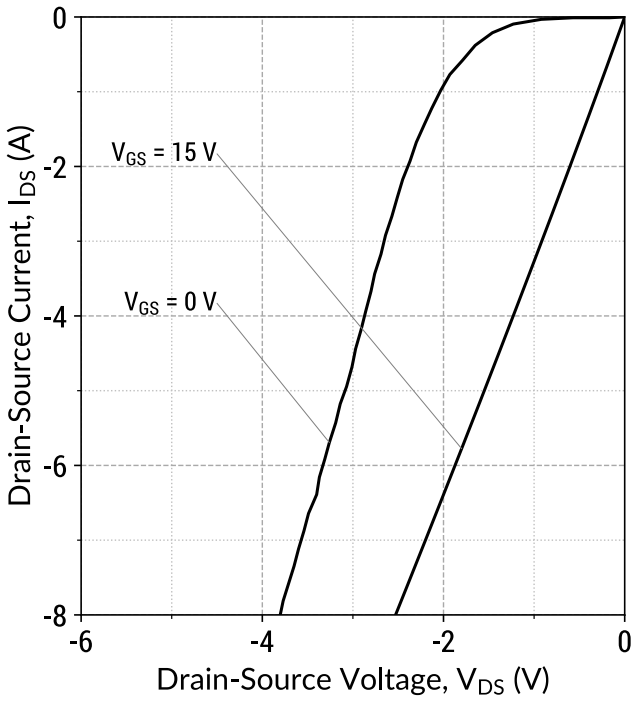
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 19: Third Quadrant Characteristics (T_j = 25°C)



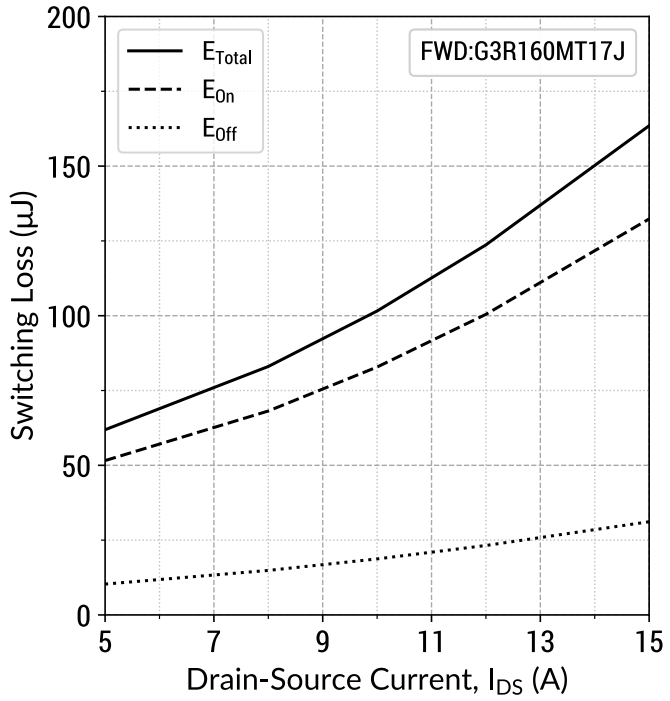
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 20: Third Quadrant Characteristics (T_j = 175°C)



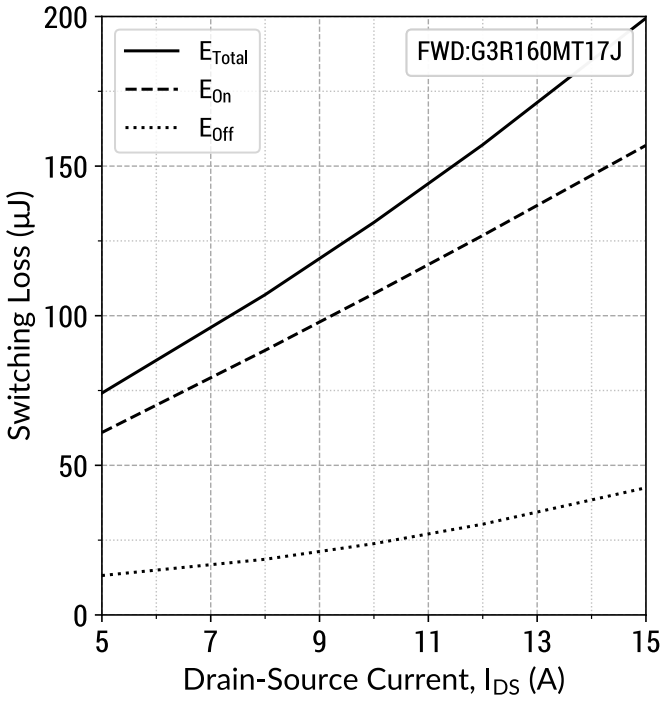
$I_D = f(V_{DS}, V_{GS})$; t_P = 250 µs

Figure 21: Inductive Switching Energy v/s Drain Current (V_{DD} = 1000V)



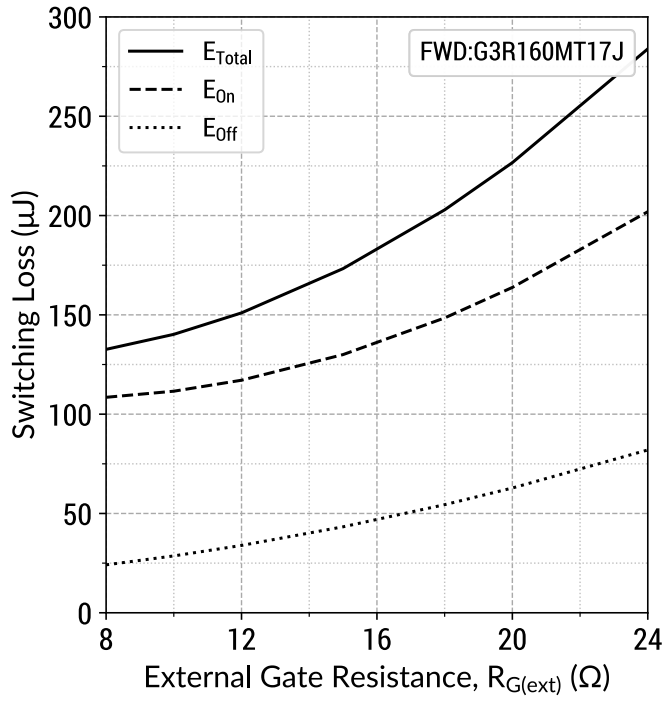
T_j = 25°C; V_{GS} = -5/+15V; $R_{G(ext)}$ = 8 Ω; L = 220.0µH

Figure 22: Inductive Switching Energy v/s Drain Current (V_{DD} = 1200V)



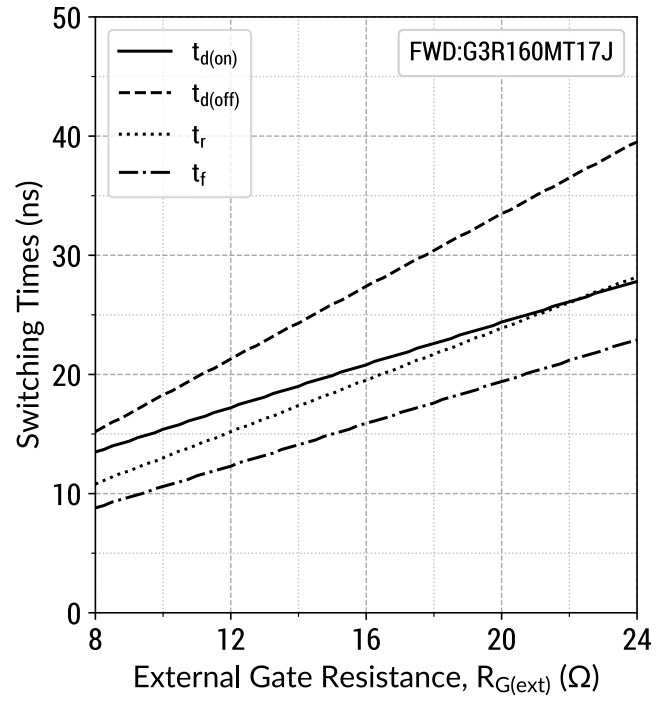
T_j = 25°C; V_{GS} = -5/+15V; $R_{G(ext)}$ = 8 Ω; L = 220.0µH

Figure 23: Inductive Switching Energy v/s $R_{G(ext)}$ (V_{DD} = 1200V)



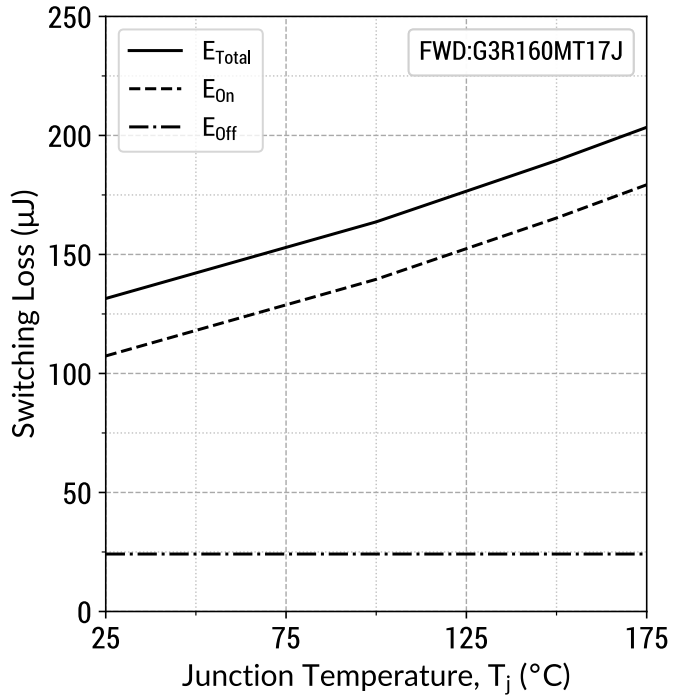
T_j = 25°C; V_{GS} = -5/+15V; I_{DS} = 10 A; L = 220.0µH

Figure 24: Switching Time v/s $R_{G(ext)}$ (V_{DD} = 1200V)



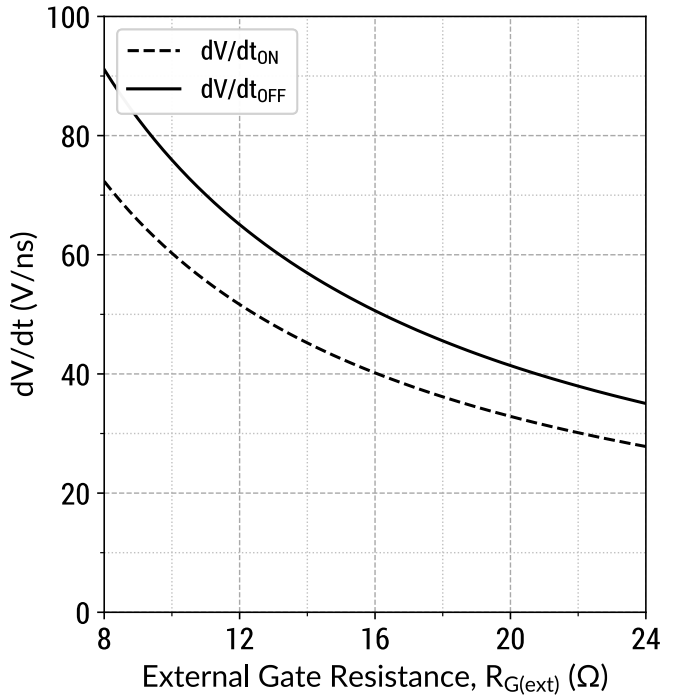
T_j = 25°C; V_{GS} = -5/+15V; I_{DS} = 10 A; L = 220.0µH

Figure 25: Inductive Switching Energy v/s Temperature (V_{DD} = 1200V)



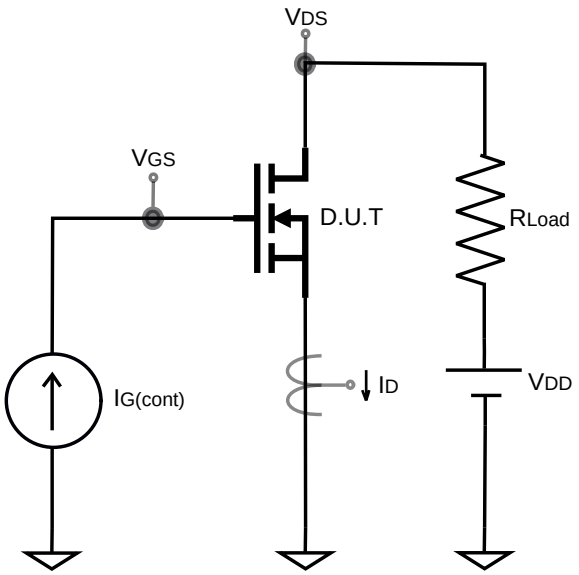
T_j = 25°C; V_{GS} = -5/+15V; $R_{G(ext)}$ = 8 Ω; I_{DS} = 10 A; L = 220.0µH

Figure 26: dV/dt v/s $R_{G(ext)}$ (V_{DD} = 1200V)

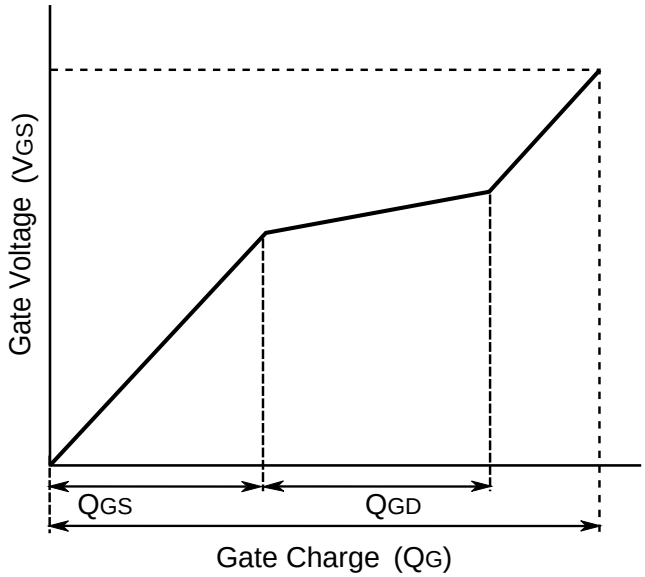


T_j = 25°C; V_{GS} = -5/+15V; I_{DS} = 10 A; L = 220.0µH

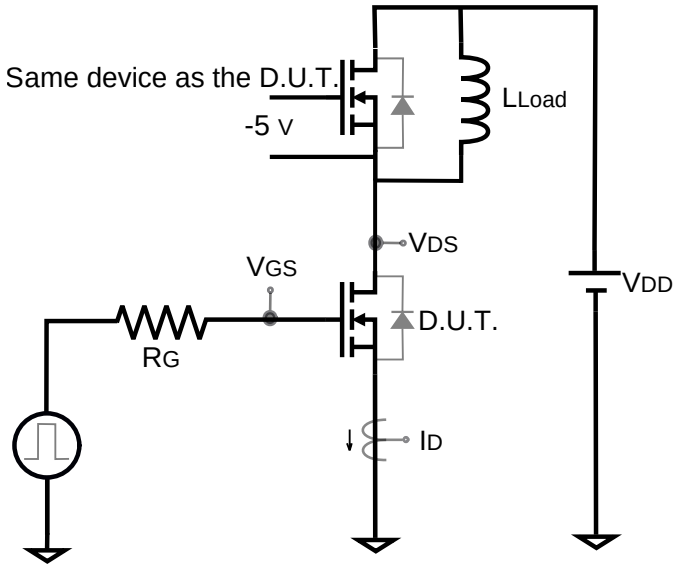
Gate Charge Circuit



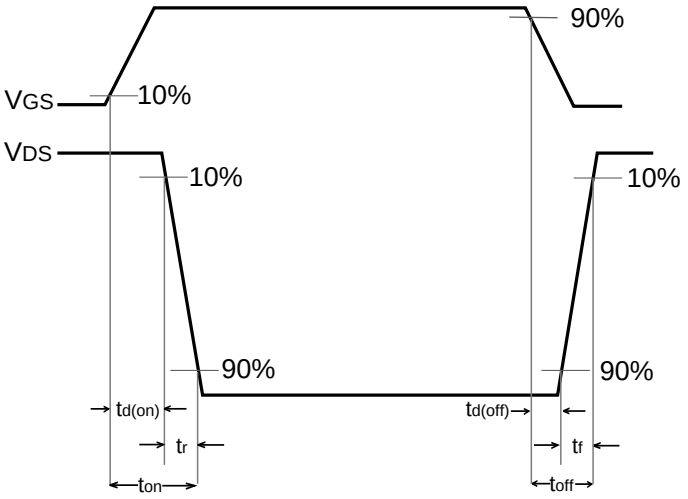
Gate Charge Waveform



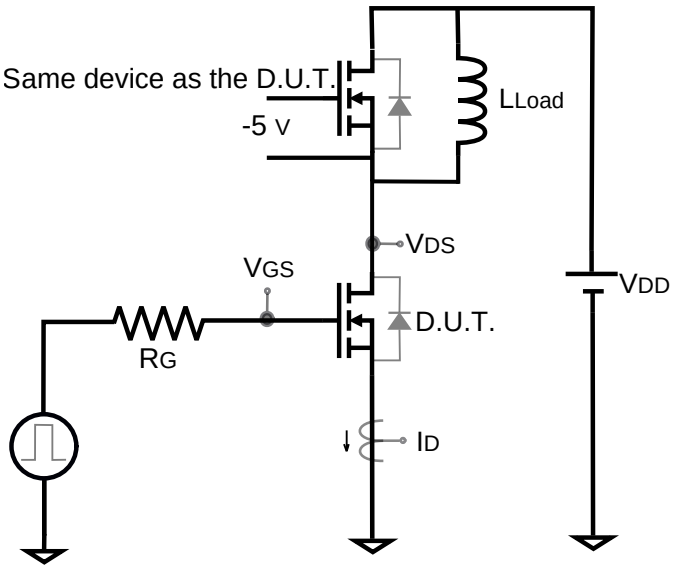
Switching Time Circuit



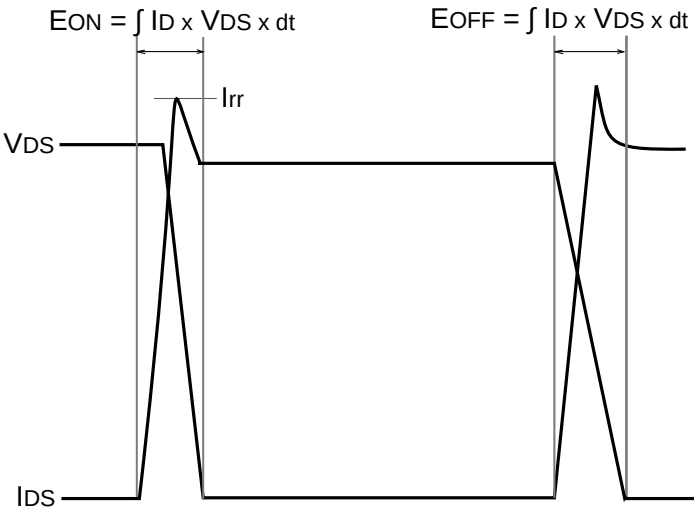
Switching Time Waveform



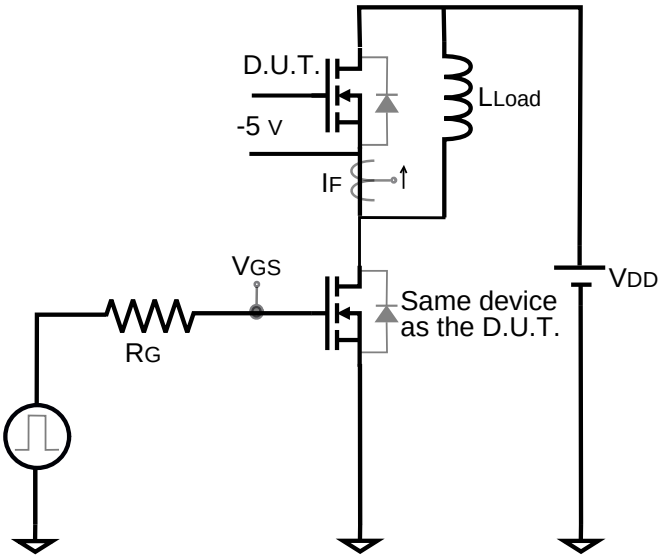
Switching Energy Circuit



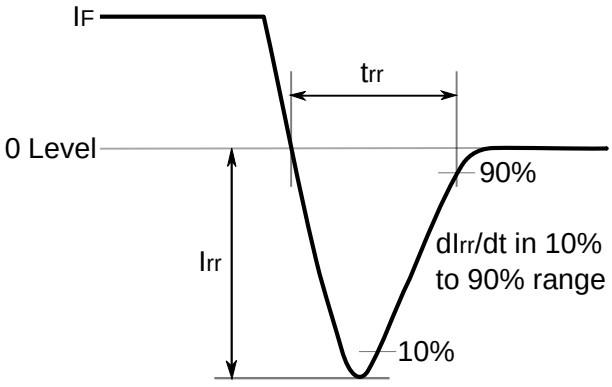
Switching Energy Waveform



Reverse Recovery Circuit

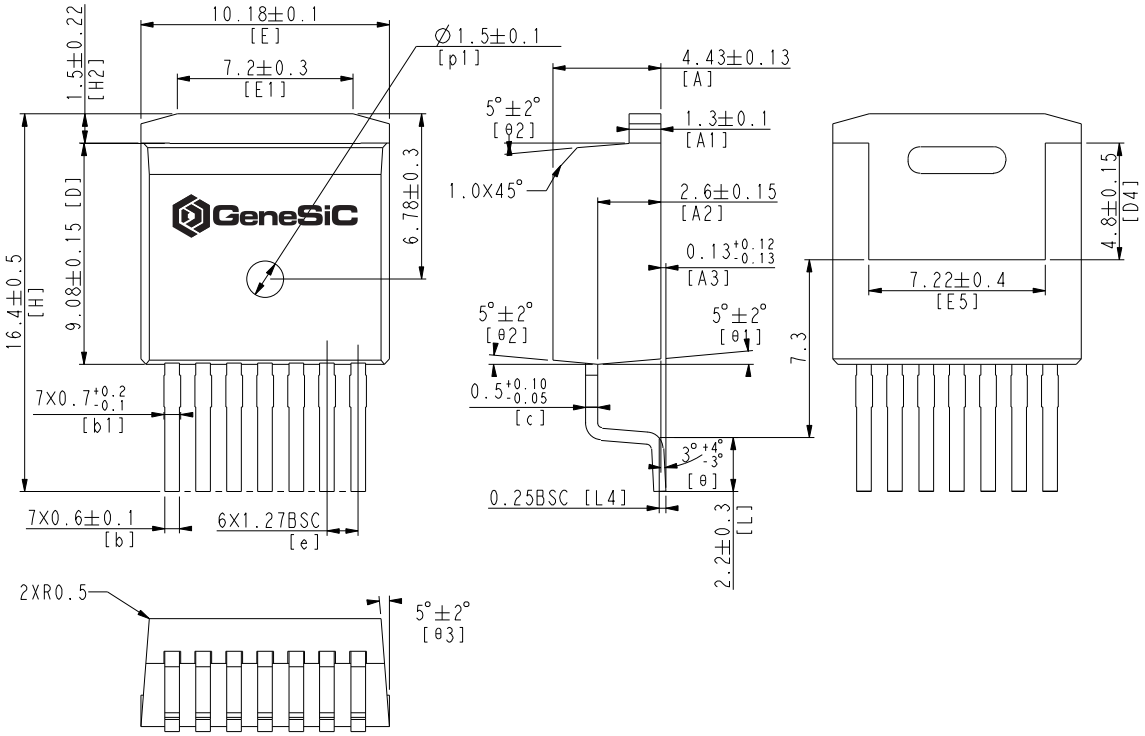


Reverse Recovery Waveform

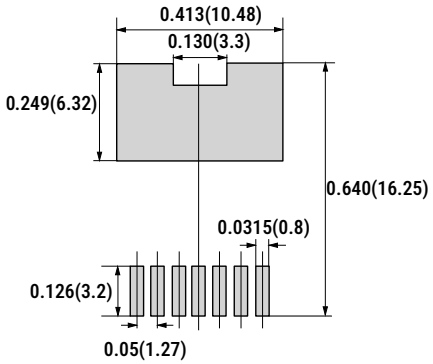


Package Dimensions

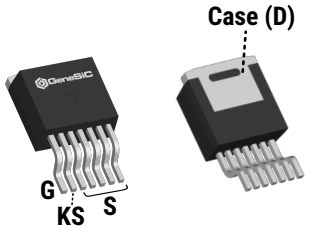
TO-263-7 Package Outline



Recommended Solder Pad Layout



Package View



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.
3. THE SOURCE AND KELVIN-SOURCE PINS ARE NOT INTERCHANGABLE. THEIR EXCHANGE MIGHT LEAD TO MALFUNCTION.

Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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Related Links

- SPICE Models: https://www.genesicsemi.com/sic-mosfet/G3R160MT17J/G3R160MT17J_SPICE.zip
- PLECS Models: https://www.genesicsemi.com/sic-mosfet/G3R160MT17J/G3R160MT17J_PLECS.zip
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- Gate Driver Reference: https://www.genesicsemi.com/technical-support
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- Reliability: https://www.genesicsemi.com/reliability
- Compliance: https://www.genesicsemi.com/compliance
- Quality Manual: https://www.genesicsemi.com/quality

Revision History

- Rev 21/May: Updated switching time and switching energy data
- Supersedes: Rev 20/Jun, Rev 20/Sep, Rev 21/Feb

www.genesicsemi.com/sic-mosfet/

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